	37 CFR 1.501 INFORMATION DISCLOSURE STATEMENT IN A PATENT				Docket No. P01,0334		Scrial No. 10/007,035			
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Sheet 1 of 1

37 CFR 1.501 INFORMATION DISCLOSURE STATEMENT IN A PATENT						Docket No. P01,0334		Serial No.			
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Examiner Stephen Winish Date Considered 9/29/05											
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if no in conformance and not considered. Include copy of this form with next communication to applicant.											